Issue Classification

Application/Control No.	Applicant(s)/Patent Under Reexamination
09739219	SHIMOYAMA, TAKESHI
Examiner	**Art Unit**
Chen, Shin-Hon	2131

ORIGINAL	
CLASS	SUBCLASS
380	29

CROSS REFERENCE(S)					
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
380	28	29	37	42	44
713	189	168			

INTERNATIONAL CLASSIFICATION	
CLAIMED	NON-CLAIMED
H 04K 1/00 (2006.01.01)	G 06F 11/30 (2006.01.01)
H 04L 9/00 (2006.01.01)	G 06F 12/14 (2006.01.01)
H 04L 9/28 (2006.01.01)	H 04L 9/32 (2006.01.01)
H 04K 1/04 (2006.01.01)	
H 04K 1/06 (2006.01.01)	

Chen, Shin-Hon (Assistant Examiner)	11/07/07 (Date)	AYAZ SHEIKH SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2100 11/8/07 (Primary Examiner) (Date)	Total Claims Allowed: 15
(Legal Instruments Examiner)	(Date)		O.G. Print Claim(s): 1 / O.G. Print Figure: 2